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### Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Obsolete
Number of LABs/CLBs	360
Number of Logic Elements/Cells	2880
Total RAM Bits	20480
Number of I/O	274
Number of Gates	116000
Voltage - Supply	3V ~ 3.6V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	356-LBGA
Supplier Device Package	356-BGA (35x35)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/intel/epf10k50vbc356-2n">https://www.e-xfl.com/product-detail/intel/epf10k50vbc356-2n</a>

The FLEX 10K architecture is similar to that of embedded gate arrays, the fastest-growing segment of the gate array market. As with standard gate arrays, embedded gate arrays implement general logic in a conventional “sea-of-gates” architecture. In addition, embedded gate arrays have dedicated die areas for implementing large, specialized functions. By embedding functions in silicon, embedded gate arrays provide reduced die area and increased speed compared to standard gate arrays. However, embedded megafunctions typically cannot be customized, limiting the designer’s options. In contrast, FLEX 10K devices are programmable, providing the designer with full control over embedded megafunctions and general logic while facilitating iterative design changes during debugging.

Each FLEX 10K device contains an embedded array and a logic array. The embedded array is used to implement a variety of memory functions or complex logic functions, such as digital signal processing (DSP), microcontroller, wide-data-path manipulation, and data-transformation functions. The logic array performs the same function as the sea-of-gates in the gate array: it is used to implement general logic, such as counters, adders, state machines, and multiplexers. The combination of embedded and logic arrays provides the high performance and high density of embedded gate arrays, enabling designers to implement an entire system on a single device.

FLEX 10K devices are configured at system power-up with data stored in an Altera serial configuration device or provided by a system controller. Altera offers the EPC1, EPC2, EPC16, and EPC1441 configuration devices, which configure FLEX 10K devices via a serial data stream. Configuration data can also be downloaded from system RAM or from Altera’s BitBlaster™ serial download cable or ByteBlasterMV™ parallel port download cable. After a FLEX 10K device has been configured, it can be reconfigured in-circuit by resetting the device and loading new data. Because reconfiguration requires less than 320 ms, real-time changes can be made during system operation.

FLEX 10K devices contain an optimized interface that permits microprocessors to configure FLEX 10K devices serially or in parallel, and synchronously or asynchronously. The interface also enables microprocessors to treat a FLEX 10K device as memory and configure the device by writing to a virtual memory location, making it very easy for the designer to reconfigure the device.

### **Asynchronous Preset**

An asynchronous preset is implemented as either an asynchronous load, or with an asynchronous clear. If DATA3 is tied to  $V_{CC}$ , asserting LABCTRL1 asynchronously loads a one into the register. Alternatively, the Altera software can provide preset control by using the clear and inverting the input and output of the register. Inversion control is available for the inputs to both LEs and IOEs. Therefore, if a register is preset by only one of the two LABCTRL signals, the DATA3 input is not needed and can be used for one of the LE operating modes.

### **Asynchronous Preset & Clear**

When implementing asynchronous clear and preset, LABCTRL1 controls the preset and LABCTRL2 controls the clear. DATA3 is tied to  $V_{CC}$ , therefore, asserting LABCTRL1 asynchronously loads a one into the register, effectively presetting the register. Asserting LABCTRL2 clears the register.

### **Asynchronous Load with Clear**

When implementing an asynchronous load in conjunction with the clear, LABCTRL1 implements the asynchronous load of DATA3 by controlling the register preset and clear. LABCTRL2 implements the clear by controlling the register clear; LABCTRL2 does not have to feed the preset circuits.

### **Asynchronous Load with Preset**

When implementing an asynchronous load in conjunction with preset, the Altera software provides preset control by using the clear and inverting the input and output of the register. Asserting LABCTRL2 presets the register, while asserting LABCTRL1 loads the register. The Altera software inverts the signal that drives DATA3 to account for the inversion of the register's output.

### **Asynchronous Load without Preset or Clear**

When implementing an asynchronous load without preset or clear, LABCTRL1 implements the asynchronous load of DATA3 by controlling the register preset and clear.

For improved routing, the row interconnect is comprised of a combination of full-length and half-length channels. The full-length channels connect to all LABs in a row; the half-length channels connect to the LABs in half of the row. The EAB can be driven by the half-length channels in the left half of the row and by the full-length channels. The EAB drives out to the full-length channels. In addition to providing a predictable, row-wide interconnect, this architecture provides increased routing resources. Two neighboring LABs can be connected using a half-row channel, thereby saving the other half of the channel for the other half of the row.

**Table 7** summarizes the FastTrack Interconnect resources available in each FLEX 10K device.

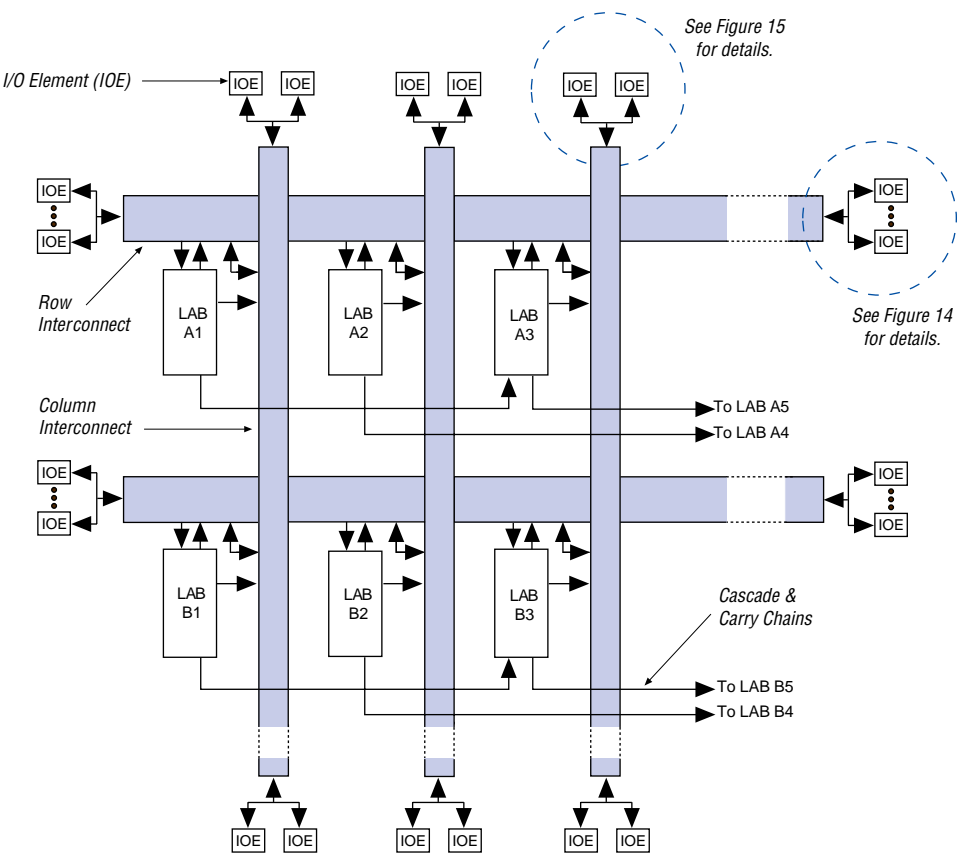
<b>Table 7. FLEX 10K FastTrack Interconnect Resources</b>				
<b>Device</b>	<b>Rows</b>	<b>Channels per Row</b>	<b>Columns</b>	<b>Channels per Column</b>
EPF10K10 EPF10K10A	3	144	24	24
EPF10K20	6	144	24	24
EPF10K30 EPF10K30A	6	216	36	24
EPF10K40	8	216	36	24
EPF10K50 EPF10K50V	10	216	36	24
EPF10K70	9	312	52	24
EPF10K100 EPF10K100A	12	312	52	24
EPF10K130V	16	312	52	32
EPF10K250A	20	456	76	40

In addition to general-purpose I/O pins, FLEX 10K devices have six dedicated input pins that provide low-skew signal distribution across the device. These six inputs can be used for global clock, clear, preset, and peripheral output enable and clock enable control signals. These signals are available as control signals for all LABs and IOEs in the device.

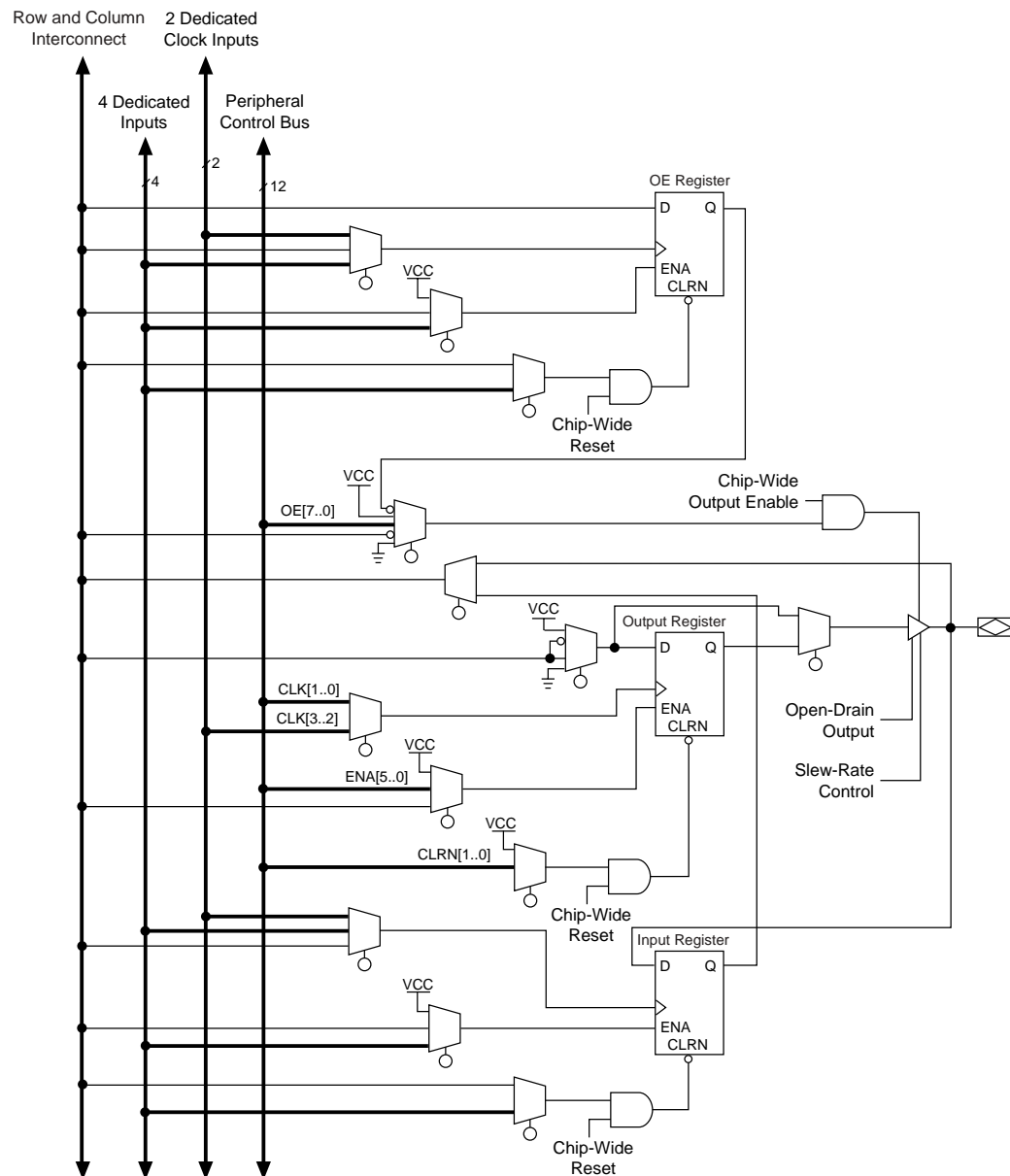
The dedicated inputs can also be used as general-purpose data inputs because they can feed the local interconnect of each LAB in the device. However, the use of dedicated inputs as data inputs can introduce additional delay into the control signal network.

Figure 12 shows the interconnection of adjacent LABs and EABs with row, column, and local interconnects, as well as the associated cascade and carry chains. Each LAB is labeled according to its location: a letter represents the row and a number represents the column. For example, LAB B3 is in row B, column 3.

Figure 12. Interconnect Resources



**Figure 13. Bidirectional I/O Registers**



**Table 18. FLEX 10K 5.0-V Device Recommended Operating Conditions**

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CCINT}$	Supply voltage for internal logic and input buffers	(3), (4)	4.75 (4.50)	5.25 (5.50)	V
$V_{CCIO}$	Supply voltage for output buffers, 5.0-V operation	(3), (4)	4.75 (4.50)	5.25 (5.50)	V
	Supply voltage for output buffers, 3.3-V operation	(3), (4)	3.00 (3.00)	3.60 (3.60)	V
$V_I$	Input voltage		−0.5	$V_{CCINT} + 0.5$	V
$V_O$	Output voltage		0	$V_{CCIO}$	V
$T_A$	Ambient temperature	For commercial use	0	70	° C
		For industrial use	−40	85	° C
$T_J$	Operating temperature	For commercial use	0	85	° C
		For industrial use	−40	100	° C
$t_R$	Input rise time			40	ns
$t_F$	Input fall time			40	ns

**Table 19. FLEX 10K 5.0-V Device DC Operating Conditions** *Notes (5), (6)*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IH}$	High-level input voltage		2.0		$V_{CCINT} + 0.5$	V
$V_{IL}$	Low-level input voltage		-0.5		0.8	V
$V_{OH}$	5.0-V high-level TTL output voltage	$I_{OH} = -4$ mA DC, $V_{CCIO} = 4.75$ V (7)	2.4			V
	3.3-V high-level TTL output voltage	$I_{OH} = -4$ mA DC, $V_{CCIO} = 3.00$ V (7)	2.4			V
	3.3-V high-level CMOS output voltage	$I_{OH} = -0.1$ mA DC, $V_{CCIO} = 3.00$ V (7)	$V_{CCIO} - 0.2$			V
$V_{OL}$	5.0-V low-level TTL output voltage	$I_{OL} = 12$ mA DC, $V_{CCIO} = 4.75$ V (8)			0.45	V
	3.3-V low-level TTL output voltage	$I_{OL} = 12$ mA DC, $V_{CCIO} = 3.00$ V (8)			0.45	V
	3.3-V low-level CMOS output voltage	$I_{OL} = 0.1$ mA DC, $V_{CCIO} = 3.00$ V (8)			0.2	V
$I_I$	Input pin leakage current	$V_I = V_{CC}$ or ground (9)	-10		10	$\mu$ A
$I_{OZ}$	Tri-stated I/O pin leakage current	$V_O = V_{CC}$ or ground (9)	-40		40	$\mu$ A
$I_{CC0}$	$V_{CC}$ supply current (standby)	$V_I =$ ground, no load		0.5	10	mA

**Table 20. 5.0-V Device Capacitance of EPF10K10, EPF10K20 & EPF10K30 Devices** *Note (10)*

Symbol	Parameter	Conditions	Min	Max	Unit
$C_{IN}$	Input capacitance	$V_{IN} = 0$ V, $f = 1.0$ MHz		8	pF
$C_{INCLK}$	Input capacitance on dedicated clock pin	$V_{IN} = 0$ V, $f = 1.0$ MHz		12	pF
$C_{OUT}$	Output capacitance	$V_{OUT} = 0$ V, $f = 1.0$ MHz		8	pF

**Table 21. 5.0-V Device Capacitance of EPF10K40, EPF10K50, EPF10K70 & EPF10K100 Devices** *Note (10)*

Symbol	Parameter	Conditions	Min	Max	Unit
$C_{IN}$	Input capacitance	$V_{IN} = 0$ V, $f = 1.0$ MHz		10	pF
$C_{INCLK}$	Input capacitance on dedicated clock pin	$V_{IN} = 0$ V, $f = 1.0$ MHz		15	pF
$C_{OUT}$	Output capacitance	$V_{OUT} = 0$ V, $f = 1.0$ MHz		10	pF



Figure 22 shows the typical output drive characteristics of EPF10K10A, EPF10K30A, EPF10K100A, and EPF10K250A devices with 3.3-V and 2.5-V  $V_{CCIO}$ . The output driver is compliant with the 3.3-V *PCI Local Bus Specification, Revision 2.2* (with 3.3-V  $V_{CCIO}$ ). Moreover, device analysis shows that the EPF10K10A, EPF10K30A, and EPF 10K100A devices can drive a 5.0-V PCI bus with eight or fewer loads.

**Figure 22. Output Drive Characteristics for EPF10K10A, EPF10K30A & EPF10K100A Devices**

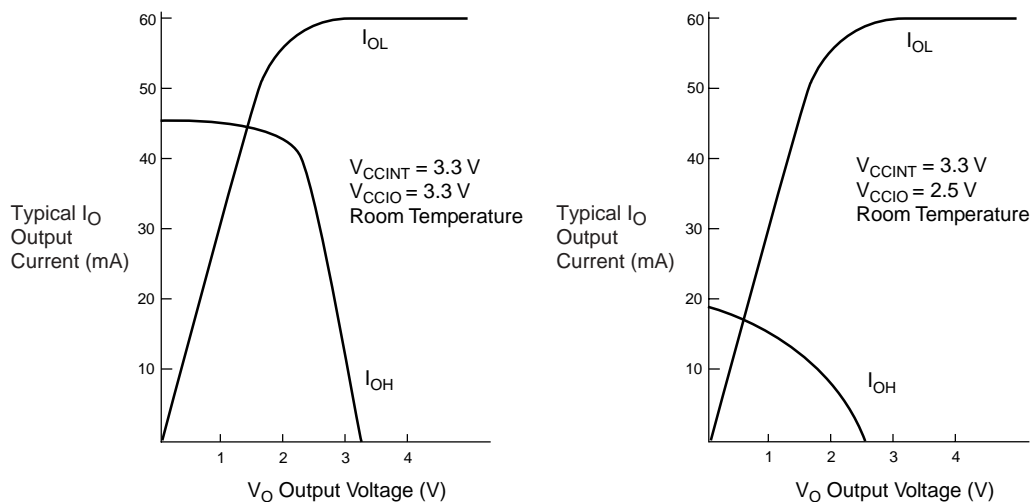


Figure 23 shows the typical output drive characteristics of the EPF10K250A device with 3.3-V and 2.5-V  $V_{CCIO}$ .

**Table 43. EPF10K10 Device Interconnect Timing Microparameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{DIN2IOE}$		4.8		6.2	ns
$t_{DIN2LE}$		2.6		3.8	ns
$t_{DIN2DATA}$		4.3		5.2	ns
$t_{DCLK2IOE}$		3.4		4.0	ns
$t_{DCLK2LE}$		2.6		3.8	ns
$t_{SAMELAB}$		0.6		0.6	ns
$t_{SAMEROW}$		3.6		3.8	ns
$t_{SAMECOLUMN}$		0.9		1.1	ns
$t_{DIFFROW}$		4.5		4.9	ns
$t_{TWOROWS}$		8.1		8.7	ns
$t_{LEPERIPH}$		3.3		3.9	ns
$t_{LABCARRY}$		0.5		0.8	ns
$t_{LABCASC}$		2.7		3.0	ns

**Table 44. EPF10K20 Device Interconnect Timing Microparameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{DIN2IOE}$		5.2		6.6	ns
$t_{DIN2LE}$		2.6		3.8	ns
$t_{DIN2DATA}$		4.3		5.2	ns
$t_{DCLK2IOE}$		4.3		4.0	ns
$t_{DCLK2LE}$		2.6		3.8	ns
$t_{SAMELAB}$		0.6		0.6	ns
$t_{SAMEROW}$		3.7		3.9	ns
$t_{SAMECOLUMN}$		1.4		1.6	ns
$t_{DIFFROW}$		5.1		5.5	ns
$t_{TWOROWS}$		8.8		9.4	ns
$t_{LEPERIPH}$		4.7		5.6	ns
$t_{LABCARRY}$		0.5		0.8	ns
$t_{LABCASC}$		2.7		3.0	ns

**Table 45. EPF10K10 & EPF10K20 Device External Timing Parameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{\text{DDR}}$		16.1		20.0	ns
$t_{\text{INSU}}$ (2), (3)	5.5		6.0		ns
$t_{\text{INH}}$ (3)	0.0		0.0		ns
$t_{\text{OUTCO}}$ (3)	2.0	6.7	2.0	8.4	ns

**Table 46. EPF10K10 Device External Bidirectional Timing Parameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{\text{INSUBIDIR}}$	4.5		5.6		ns
$t_{\text{INHBIDIR}}$	0.0		0.0		ns
$t_{\text{OUTCOBIDIR}}$	2.0	6.7	2.0	8.4	ns
$t_{\text{XZBIDIR}}$		10.5		13.4	ns
$t_{\text{ZXBIDIR}}$		10.5		13.4	ns

**Table 47. EPF10K20 Device External Bidirectional Timing Parameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{\text{INSUBIDIR}}$	4.6		5.7		ns
$t_{\text{INHBIDIR}}$	0.0		0.0		ns
$t_{\text{OUTCOBIDIR}}$	2.0	6.7	2.0	8.4	ns
$t_{\text{XZBIDIR}}$		10.5		13.4	ns
$t_{\text{ZXBIDIR}}$		10.5		13.4	ns

**Notes to tables:**

- (1) All timing parameters are described in Tables 32 through 38 in this data sheet.
- (2) Using an LE to register the signal may provide a lower setup time.
- (3) This parameter is specified by characterization.

**Table 49. EPF10K30, EPF10K40 & EPF10K50 Device IOE Timing Microparameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{IOD}$		0.4		0.6	ns
$t_{IOC}$		0.5		0.9	ns
$t_{IOCO}$		0.4		0.5	ns
$t_{IOCOMB}$		0.0		0.0	ns
$t_{IOSU}$	3.1		3.5		ns
$t_{IOH}$	1.0		1.9		ns
$t_{IOCLR}$		1.0		1.2	ns
$t_{OD1}$		3.3		3.6	ns
$t_{OD2}$		5.6		6.5	ns
$t_{OD3}$		7.0		8.3	ns
$t_{XZ}$		5.2		5.5	ns
$t_{ZX1}$		5.2		5.5	ns
$t_{ZX2}$		7.5		8.4	ns
$t_{ZX3}$		8.9		10.2	ns
$t_{INREG}$		7.7		10.0	ns
$t_{IOFD}$		3.3		4.0	ns
$t_{INCOMB}$		3.3		4.0	ns

**Table 50. EPF10K30, EPF10K40 & EPF10K50 Device EAB Internal Microparameters** *Note (1)*

Symbol	-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	
$t_{EABDATA1}$		1.5		1.9	ns
$t_{EABDATA2}$		4.8		6.0	ns
$t_{EABWE1}$		1.0		1.2	ns
$t_{EABWE2}$		5.0		6.2	ns
$t_{EABCLK}$		1.0		2.2	ns
$t_{EABCO}$		0.5		0.6	ns
$t_{EABYPASS}$		1.5		1.9	ns
$t_{EABSU}$	1.5		1.8		ns
$t_{EABH}$	2.0		2.5		ns
$t_{AA}$		8.7		10.7	ns
$t_{WP}$	5.8		7.2		ns
$t_{WDSU}$	1.6		2.0		ns
$t_{WDH}$	0.3		0.4		ns
$t_{WASU}$	0.5		0.6		ns
$t_{WAH}$	1.0		1.2		ns
$t_{WO}$		5.0		6.2	ns
$t_{DD}$		5.0		6.2	ns
$t_{EABOUT}$		0.5		0.6	ns
$t_{EABCH}$	4.0		4.0		ns
$t_{EABCL}$	5.8		7.2		ns

**Table 73. EPF10K50V Device EAB Internal Microparameters** *Note (1)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	Min	Max	
$t_{EABDATA1}$		1.7		2.8		3.4		4.6	ns
$t_{EABDATA2}$		4.9		3.9		4.8		5.9	ns
$t_{EABWE1}$		0.0		2.5		3.0		3.7	ns
$t_{EABWE2}$		4.0		4.1		5.0		6.2	ns
$t_{EABCLK}$		0.4		0.8		1.0		1.2	ns
$t_{EABCO}$		0.1		0.2		0.3		0.4	ns
$t_{EABYPASS}$		0.9		1.1		1.3		1.6	ns
$t_{EABSU}$	0.8		1.5		1.8		2.2		ns
$t_{EABH}$	0.8		1.6		2.0		2.5		ns
$t_{AA}$		5.5		8.2		10.0		12.4	ns
$t_{WP}$	6.0		4.9		6.0		7.4		ns
$t_{WDSU}$	0.1		0.8		1.0		1.2		ns
$t_{WDH}$	0.1		0.2		0.3		0.4		ns
$t_{WASU}$	0.1		0.4		0.5		0.6		ns
$t_{WAH}$	0.1		0.8		1.0		1.2		ns
$t_{WO}$		2.8		4.3		5.3		6.5	ns
$t_{DD}$		2.8		4.3		5.3		6.5	ns
$t_{EABOUT}$		0.5		0.4		0.5		0.6	ns
$t_{EABCH}$	2.0		4.0		4.0		4.0		ns
$t_{EABCL}$	6.0		4.9		6.0		7.4		ns

**Table 74. EPF10K50V Device EAB Internal Timing Macroparameters** *Note (1)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	Min	Max	
$t_{EABAA}$		9.5		13.6		16.5		20.8	ns
$t_{EABRCCOMB}$	9.5		13.6		16.5		20.8		ns
$t_{EABRCREG}$	6.1		8.8		10.8		13.4		ns
$t_{EABWP}$	6.0		4.9		6.0		7.4		ns
$t_{EABWCCOMB}$	6.2		6.1		7.5		9.2		ns
$t_{EABWCREG}$	12.0		11.6		14.2		17.4		ns
$t_{EABDD}$		6.8		9.7		11.8		14.9	ns
$t_{EABDATACO}$		1.0		1.4		1.8		2.2	ns
$t_{EABDATASU}$	5.3		4.6		5.6		6.9		ns
$t_{EABDATAH}$	0.0		0.0		0.0		0.0		ns
$t_{EABWESU}$	4.4		4.8		5.8		7.2		ns
$t_{EABWEH}$	0.0		0.0		0.0		0.0		ns
$t_{EABWDSU}$	1.8		1.1		1.4		2.1		ns
$t_{EABWDH}$	0.0		0.0		0.0		0.0		ns
$t_{EABWASU}$	4.5		4.6		5.6		7.4		ns
$t_{EABWAH}$	0.0		0.0		0.0		0.0		ns
$t_{EABWO}$		5.1		9.4		11.4		14.0	ns

**Table 82. EPF10K130V Device Interconnect Timing Microparameters** *Note (1)*

Symbol	-2 Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{DIN2IOE}$		8.0		9.0		9.5	ns
$t_{DIN2LE}$		2.4		3.0		3.1	ns
$t_{DIN2DATA}$		5.0		6.3		7.4	ns
$t_{DCLK2IOE}$		3.6		4.6		5.1	ns
$t_{DCLK2LE}$		2.4		3.0		3.1	ns
$t_{SAMELAB}$		0.4		0.6		0.8	ns
$t_{SAMEROW}$		4.5		5.3		6.5	ns
$t_{SAMECOLUMN}$		9.0		9.5		9.7	ns
$t_{DIFFROW}$		13.5		14.8		16.2	ns
$t_{TWOROWS}$		18.0		20.1		22.7	ns
$t_{LEPERIPH}$		8.1		8.6		9.5	ns
$t_{LABCARRY}$		0.6		0.8		1.0	ns
$t_{LABCASC}$		0.8		1.0		1.2	ns

**Table 83. EPF10K130V Device External Timing Parameters** *Note (1)*

Symbol	-2 Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{DRR}$		15.0		19.1		24.2	ns
$t_{INSU}$ (2), (3)	6.9		8.6		11.0		ns
$t_{INH}$ (3)	0.0		0.0		0.0		ns
$t_{OUTCO}$ (3)	2.0	7.8	2.0	9.9	2.0	11.3	ns

**Table 84. EPF10K130V Device External Bidirectional Timing Parameters** *Note (1)*

Symbol	-2 Speed Grade		-3 Speed Grade		-4 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{INSUBIDIR}$	6.7		8.5		10.8		ns
$t_{INHBIDIR}$	0.0		0.0		0.0		ns
$t_{OUTCOBIDIR}$	2.0	6.9	2.0	8.8	2.0	10.2	ns
$t_{XZBIDIR}$		12.9		16.4		19.3	ns
$t_{ZXBIDIR}$		12.9		16.4		19.3	ns



**Table 93. EPF10K30A Device IOE Timing Microparameters** *Note (1) (Part 2 of 2)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{IOH}$	0.9		1.1		1.4		ns
$t_{IOCLR}$		0.7		0.8		1.0	ns
$t_{OD1}$		1.9		2.2		2.9	ns
$t_{OD2}$		4.8		5.6		7.3	ns
$t_{OD3}$		7.0		8.2		10.8	ns
$t_{XZ}$		2.2		2.6		3.4	ns
$t_{ZX1}$		2.2		2.6		3.4	ns
$t_{ZX2}$		5.1		6.0		7.8	ns
$t_{ZX3}$		7.3		8.6		11.3	ns
$t_{INREG}$		4.4		5.2		6.8	ns
$t_{IOFD}$		3.8		4.5		5.9	ns
$t_{INCOMB}$		3.8		4.5		5.9	ns

**Table 94. EPF10K30A Device EAB Internal Microparameters** *Note (1)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{EABDATA1}$		5.5		6.5		8.5	ns
$t_{EABDATA2}$		1.1		1.3		1.8	ns
$t_{EABWE1}$		2.4		2.8		3.7	ns
$t_{EABWE2}$		2.1		2.5		3.2	ns
$t_{EABCLK}$		0.0		0.0		0.2	ns
$t_{EABCO}$		1.7		2.0		2.6	ns
$t_{EABYPASS}$		0.0		0.0		0.3	ns
$t_{EABSU}$	1.2		1.4		1.9		ns
$t_{EABH}$	0.1		0.1		0.3		ns
$t_{AA}$		4.2		5.0		6.5	ns
$t_{WP}$	3.8		4.5		5.9		ns
$t_{WDSU}$	0.1		0.1		0.2		ns
$t_{WDH}$	0.1		0.1		0.2		ns
$t_{WASU}$	0.1		0.1		0.2		ns
$t_{WAH}$	0.1		0.1		0.2		ns
$t_{WO}$		3.7		4.4		6.4	ns
$t_{DD}$		3.7		4.4		6.4	ns
$t_{EABOUT}$		0.0		0.1		0.6	ns
$t_{EABCH}$	3.0		3.5		4.0		ns
$t_{EABCL}$	3.8		4.5		5.9		ns

**Table 102. EPF10K100A Device EAB Internal Timing Macroparameters** *Note (1)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{EABAA}$		6.8		7.8		9.2	ns
$t_{EABRCCOMB}$	6.8		7.8		9.2		ns
$t_{EABRCREG}$	5.4		6.2		7.4		ns
$t_{EABWP}$	3.2		3.7		4.4		ns
$t_{EABWCCOMB}$	3.4		3.9		4.7		ns
$t_{EABWCREG}$	9.4		10.8		12.8		ns
$t_{EABDD}$		6.1		6.9		8.2	ns
$t_{EABDATA CO}$		2.1		2.3		2.9	ns
$t_{EABDATASU}$	3.7		4.3		5.1		ns
$t_{EABDATAH}$	0.0		0.0		0.0		ns
$t_{EABWESU}$	2.8		3.3		3.8		ns
$t_{EABWEH}$	0.0		0.0		0.0		ns
$t_{EABWDSU}$	3.4		4.0		4.6		ns
$t_{EABWDH}$	0.0		0.0		0.0		ns
$t_{EABWASU}$	1.9		2.3		2.6		ns
$t_{EABWAH}$	0.0		0.0		0.0		ns
$t_{EABWO}$		5.1		5.7		6.9	ns

## Notes to tables:

- (1) All timing parameters are described in Tables 32 through 38 in this data sheet.
- (2) Using an LE to register the signal may provide a lower setup time.
- (3) This parameter is specified by characterization.

Tables 106 through 112 show EPF10K250A device internal and external timing parameters.

Table 106. EPF10K250A Device LE Timing Microparameters <span style="color: green;">Note (1)</span>							
Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{LUT}$		0.9		1.0		1.4	ns
$t_{CLUT}$		1.2		1.3		1.6	ns
$t_{RLUT}$		2.0		2.3		2.7	ns
$t_{PACKED}$		0.4		0.4		0.5	ns
$t_{EN}$		1.4		1.6		1.9	ns
$t_{CICO}$		0.2		0.3		0.3	ns
$t_{CGEN}$		0.4		0.6		0.6	ns
$t_{CGENR}$		0.8		1.0		1.1	ns
$t_{CASC}$		0.7		0.8		1.0	ns
$t_C$		1.2		1.3		1.6	ns
$t_{CO}$		0.6		0.7		0.9	ns
$t_{COMB}$		0.5		0.6		0.7	ns
$t_{SU}$	1.2		1.4		1.7		ns
$t_H$	1.2		1.3		1.6		ns
$t_{PRE}$		0.7		0.8		0.9	ns
$t_{CLR}$		0.7		0.8		0.9	ns
$t_{CH}$	2.5		3.0		3.5		ns
$t_{CL}$	2.5		3.0		3.5		ns

**Table 108. EPF10K250A Device EAB Internal Microparameters** *Note (1)*

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	
$t_{EABDATA1}$		1.3		1.5		1.7	ns
$t_{EABDATA2}$		1.3		1.5		1.7	ns
$t_{EABWE1}$		0.9		1.1		1.3	ns
$t_{EABWE2}$		5.0		5.7		6.7	ns
$t_{EABCLK}$		0.6		0.7		0.8	ns
$t_{EABCO}$		0.0		0.0		0.0	ns
$t_{EABYPASS}$		0.1		0.1		0.2	ns
$t_{EABSU}$	3.8		4.3		5.0		ns
$t_{EABH}$	0.7		0.8		0.9		ns
$t_{AA}$		4.5		5.0		5.9	ns
$t_{WP}$	5.6		6.4		7.5		ns
$t_{WDSU}$	1.3		1.4		1.7		ns
$t_{WDH}$	0.1		0.1		0.2		ns
$t_{WASU}$	0.1		0.1		0.2		ns
$t_{WAH}$	0.1		0.1		0.2		ns
$t_{WO}$		4.1		4.6		5.5	ns
$t_{DD}$		4.1		4.6		5.5	ns
$t_{EABOUT}$		0.1		0.1		0.2	ns
$t_{EABCH}$	2.5		3.0		3.5		ns
$t_{EABCL}$	5.6		6.4		7.5		ns